CoolMOS™ Power Transistor

Features

- Intrinsic fast-recovery body diode
- Extremely low reverse recovery charge
- Ultra low gate charge
- Extreme d*v*/d*t* rated
- High peak current capability
- Qualified for industrial grade applications according to JEDEC[1)]
- **Halogen free mold compound**

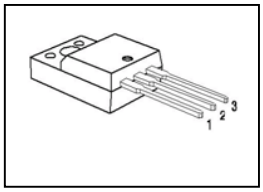
CoolMOS CFD designed for:

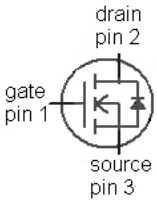
- Soft switching PWM Stages
- LCD & CRT TV

Product Summary

V_{DS} @T_{jmax}	650	V
$R_{DS(on),max}$	0.7	Ω
I_D	6.6	A

PG-TO220 FP





Type	Package	Marking
SPA07N60CFD	PG-TO220FP	07N60CFD

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current[2)]	I_D	T_C=25 °C	6.6	A
		T_C=100 °C	4.3	
Pulsed drain current[3)]	$I_{D,pulse}$	T_C=25 °C	17	
Avalanche energy, single pulse	E_{AS}	I_D=3.3 A, V_{DD}=50 V	230	mJ
Avalanche energy, repetitive[3),4)]	E_{AR}	I_D=6.6 A, V_{DD}=50 V	0.5	
Avalanche current, repetitive[3),4)]	I_{AR}		6.6	A
Drain source voltage slope	d*v*/d*t*	I_D=6.6 A, V_{DS}=480 V, T_j=125°C	80	V/ns
Reverse diode d*v*/d*t*	d*v*/d*t*	I_S=6.6 A, V_{DS}=480 V, T_j=125 °C	40	V/ns
Maximum diode commutation speed	d*i*/d*t*		600	A/µs
Gate source voltage	V_{GS}	static	±20	V
		AC (*f*>1 Hz)	±30	
Power dissipation	P_{tot}	T_C=25 °C	32	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
Mounting torque		M3 & M3.5 screws	50	Ncm

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	3.9	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wave soldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=250 µA	600	-	-	V
Avalanche breakdown voltage	$V_{(BR)DS}$	V_{GS}=0 V, I_D=6.6 A	-	700	-	
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=300 µA	3	4	5	
Zero gate voltage drain current	I_{DSS}	V_{DS}=600 V, V_{GS}=0 V, T_j=25 °C	-	0.6	-	µA
		V_{DS}=600 V, V_{GS}=0 V, T_j=150 °C	-	630	-	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=4.6 A, T_j=25 °C	-	0.59	0.7	Ω
		V_{GS}=10 V, I_D=4.6 A, T_j=150 °C	-	1.6	-	
Gate resistance	R_G	f=1 MHz, open drain	-	1.2	-	
Transconductance	g_{fs}	$\|V_{DS}\|>2\|I_D\|R_{DS(on)max}$, I_D=4.6 A	-	5.0	-	S

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=25 V, f=1 MHz	-	790	-	pF
Output capacitance	C_{oss}		-	260	-	
Reverse transfer capacitance	C_{rss}		-	16	-	
Effective output capacitance, energy related[5)]	$C_{o(er)}$	V_{GS}=0 V, V_{DS}=0 V to 480 V	-	30	-	
Effective output capacitance, time related[6)]	$C_{o(tr)}$		-	55	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=400 V, V_{GS}=10 V, I_D=6.6 A, R_G=6.8 Ω	-	12	-	ns
Rise time	t_r		-	25	-	
Turn-off delay time	$t_{d(off)}$		-	36	-	
Fall time	t_f		-	9	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=480 V, I_D=6.6A, V_{GS}=0 to 10 V	-	6.6	-	nC
Gate to drain charge	Q_{gd}		-	20	-	
Gate charge total	Q_g		-	35	47	
Gate plateau voltage	$V_{plateau}$		-	7.2	-	V

[1)] J-STD20 and JESD22

[2)] Limited only by maximum temperature

[3)] Pulse width t_p limited by $T_{j,max}$

[4)] Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

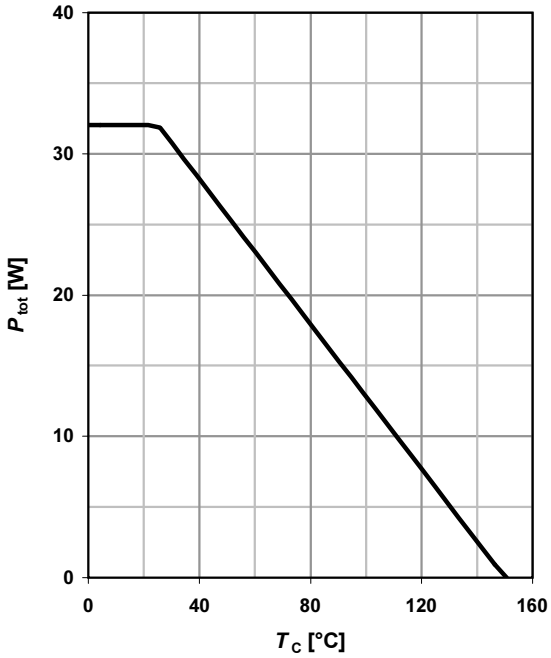
[5)] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

[6)] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Reverse Diode						
Diode continuous forward current[2]	I_S	T_C=25 °C	-	-	6.6	A
Diode pulse current[3]	$I_{S,pulse}$		-	-	17	
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=I_S, T_j=25 °C	-	1.0	1.2	V
Reverse recovery time	t_{rr}	V_R=480 V, I_F=I_S, di_F/dt=100 A/µs	-	104	-	ns
Reverse recovery charge	Q_{rr}		-	0.5	-	µC
Peak reverse recovery current	I_{rrm}		-	8	-	A
Peak rate of fall of reverse recovery current	di_{rr}/dt	T_j=25 °C	-	1000	-	A/µs

1 Power dissipation

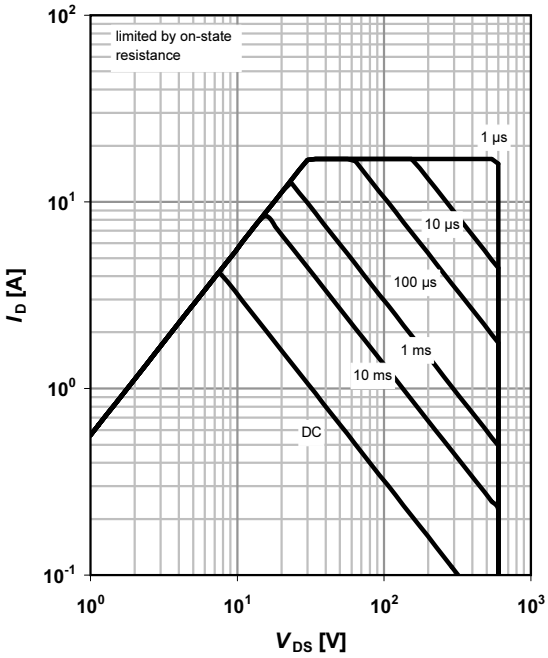
$P_{tot}=f(T_C)$



2 Safe operating area

$I_D=f(V_{DS})$; $T_C=25$ °C; $D=0$

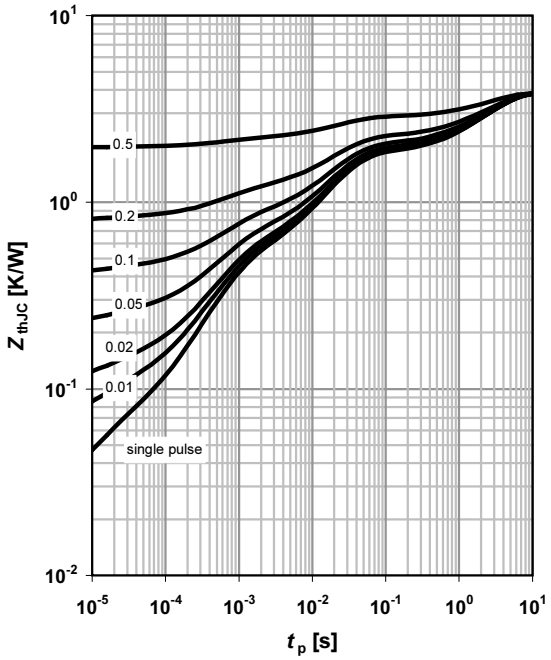
parameter: t_p



3 Max. transient thermal impedance

$I_D=f(V_{DS})$; $T_j=25$ °C

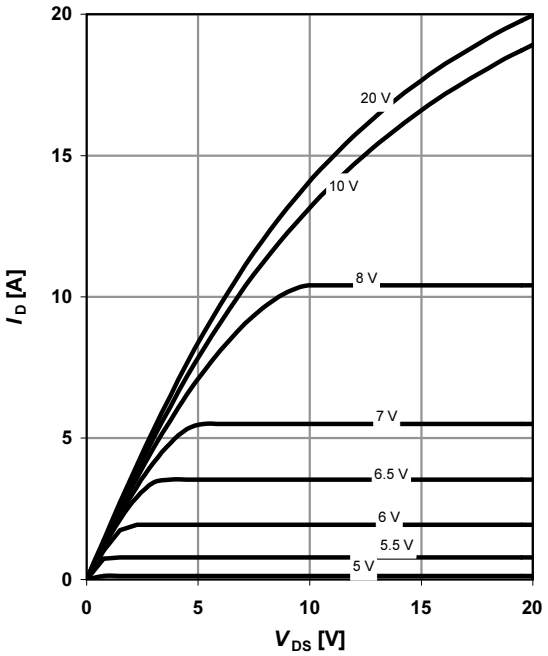
parameter: $D=t_p/T$



4 Typ. output characteristics

$I_D=f(V_{DS})$; $T_j=25$ °C

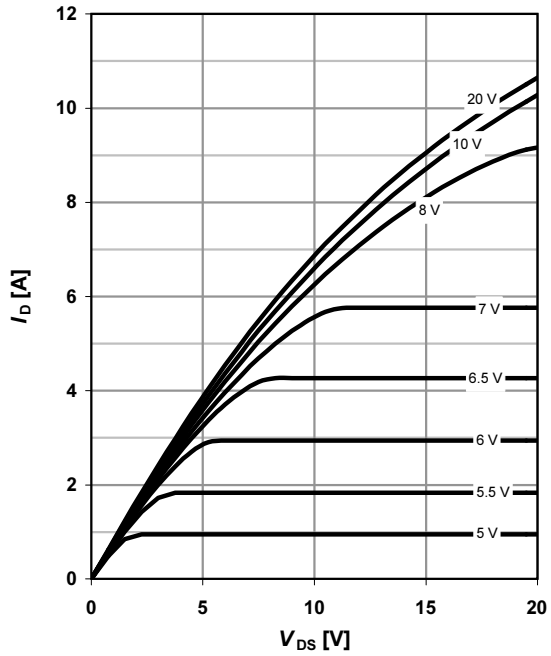
parameter: V_{GS}



5 Typ. output characteristics

I_D=f(V_{DS}); T_j=150 °C

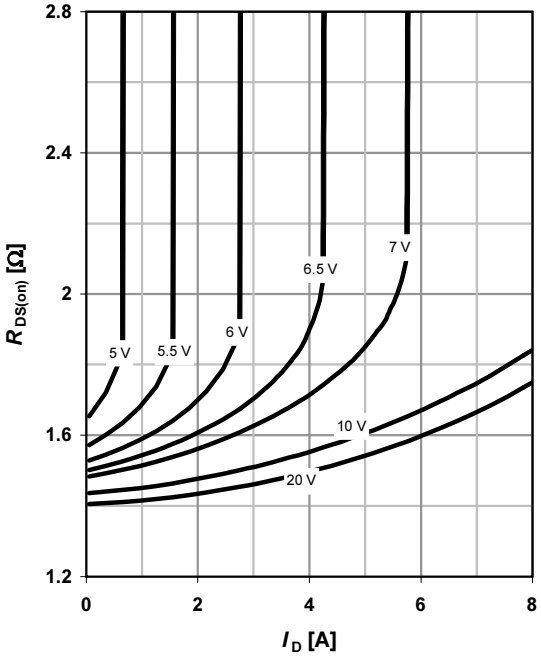
parameter: V_{GS}



6 Typ. drain-source on-state resistance

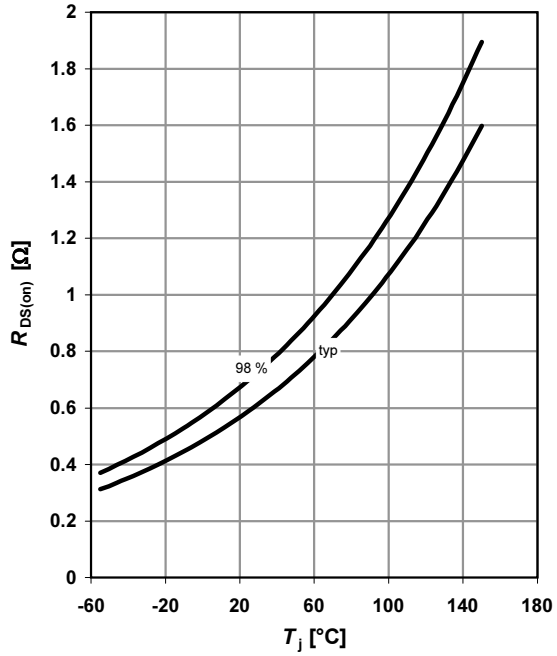
$R_{DS(on)}$=f(I_D); T_j=150 °C

parameter: V_{GS}



7 Drain-source on-state resistance

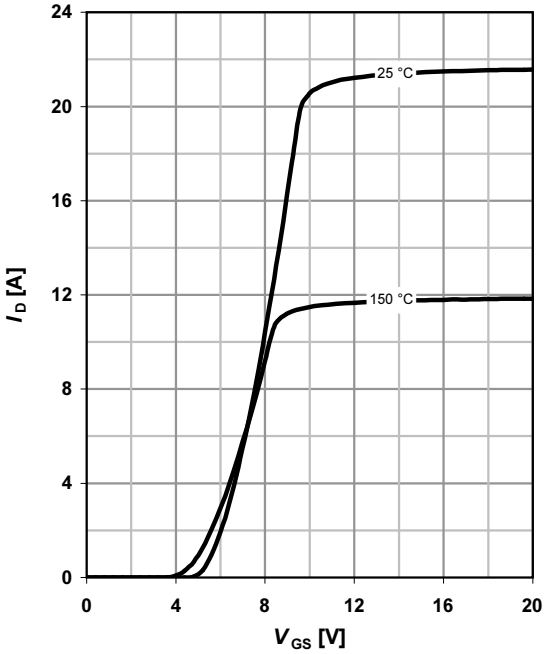
$R_{DS(on)}$=f(T_j); I_D=4.6 A; V_{GS}=10 V



8 Typ. transfer characteristics

I_D=f(V_{GS}); |V_{DS}|>2|I_D|$R_{DS(on)max}$

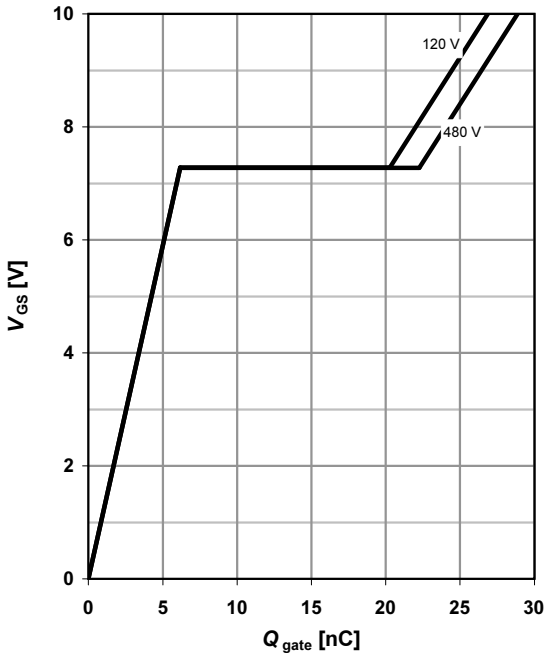
parameter: T_j



9 Typ. gate charge

V_{GS}=f(Q_{gate}); I_D=6.6 A pulsed

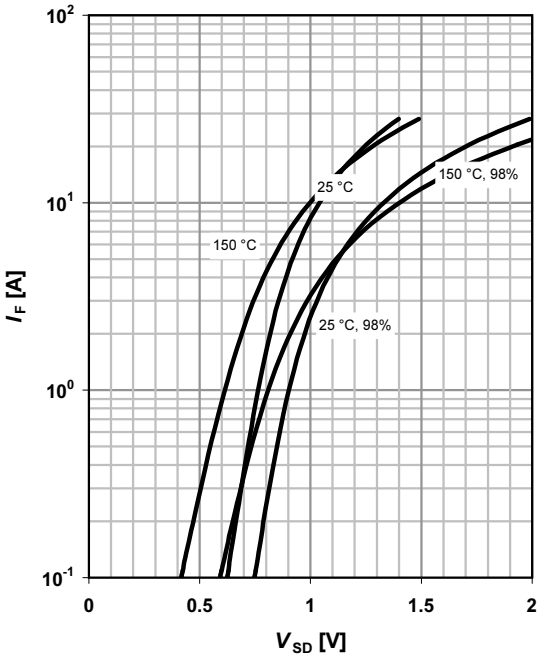
parameter: V_{DD}



10 Forward characteristics of reverse diode

I_F=f(V_{SD})

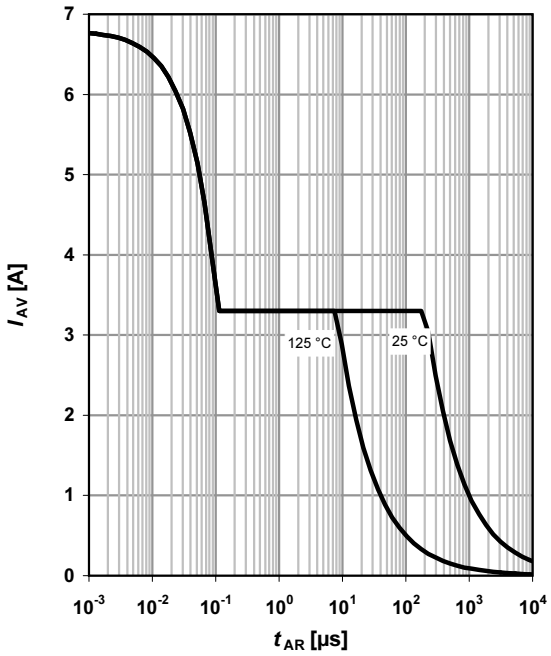
parameter: T_j



11 Avalanche SOA

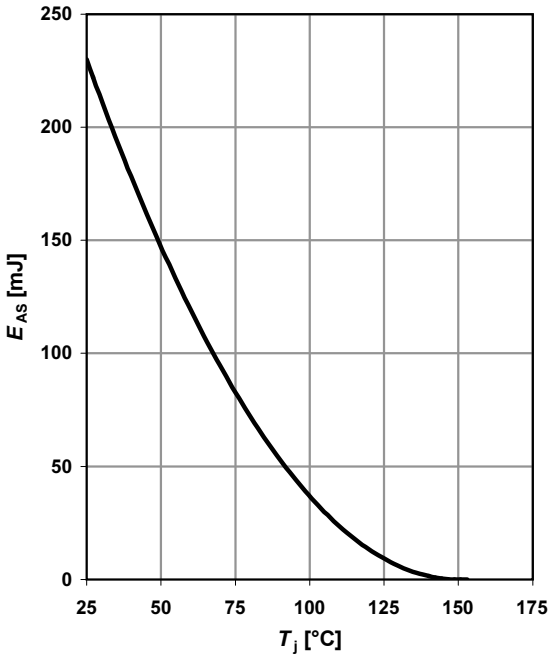
I_{AR}=f(t_{AR})

parameter: $T_{j(start)}$



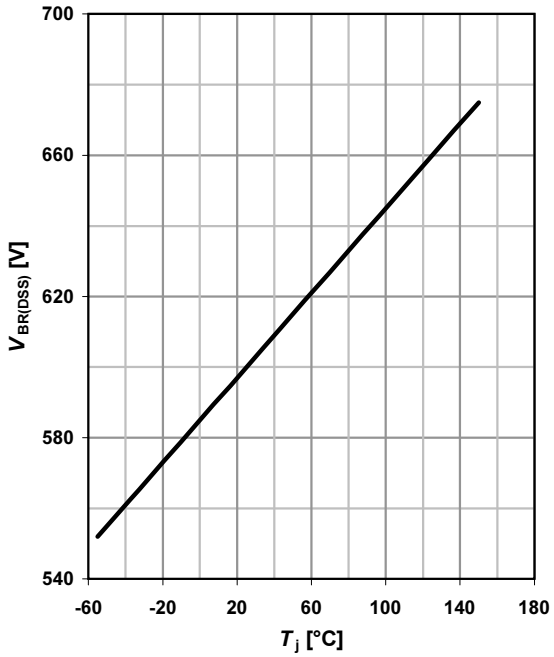
12 Avalanche energy

E_{AS}=f(T_j); I_D=3.3 A; V_{DD}=50 V



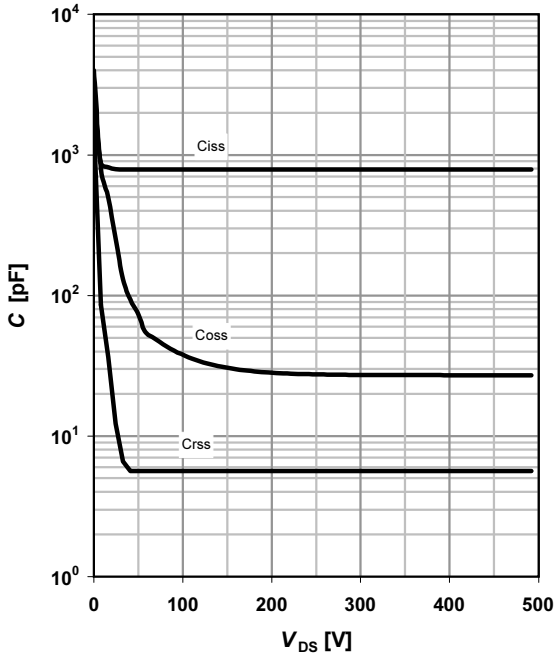
13 Drain-source breakdown voltage

$V_{BR(DSS)}$=f(T_j);



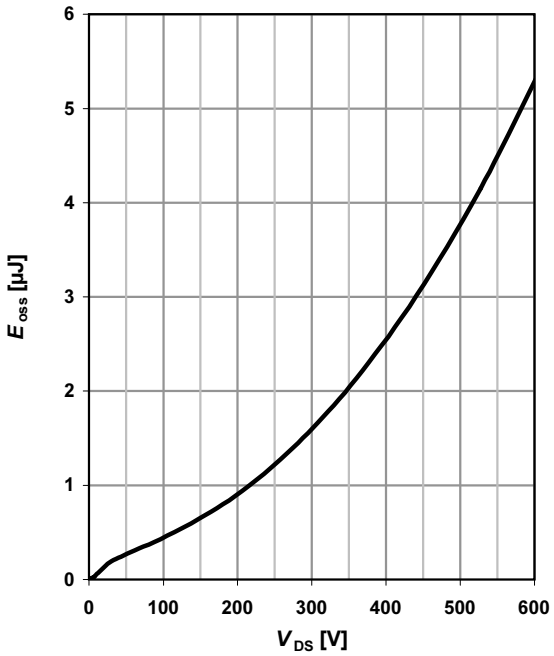
14 Typ. capacitances

C=f(V_{DS}); V_{GS}=0 V; f=1 MHz



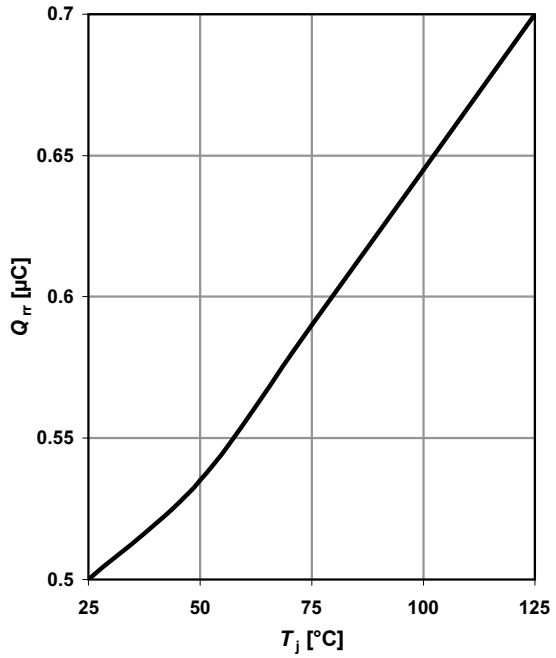
15 Typ. C_{oss} stored energy

E_{oss}= f(V_{DS})



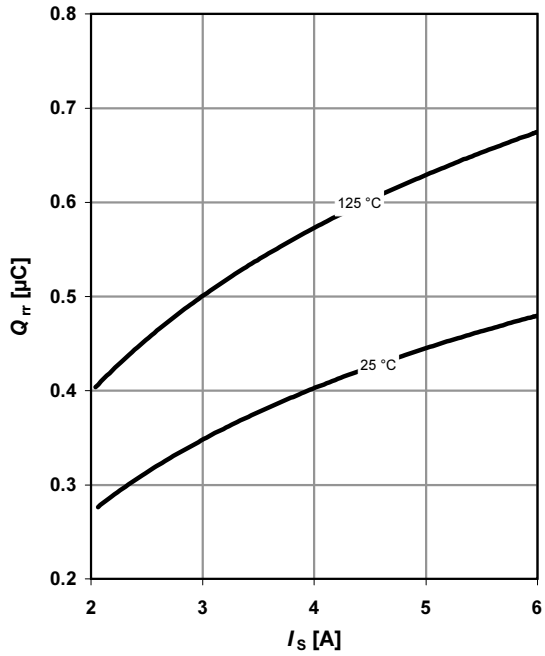
16 Typ. reverse recovery charge

Q_{rr}=f(T_j);parameter: I_D =6.6 A



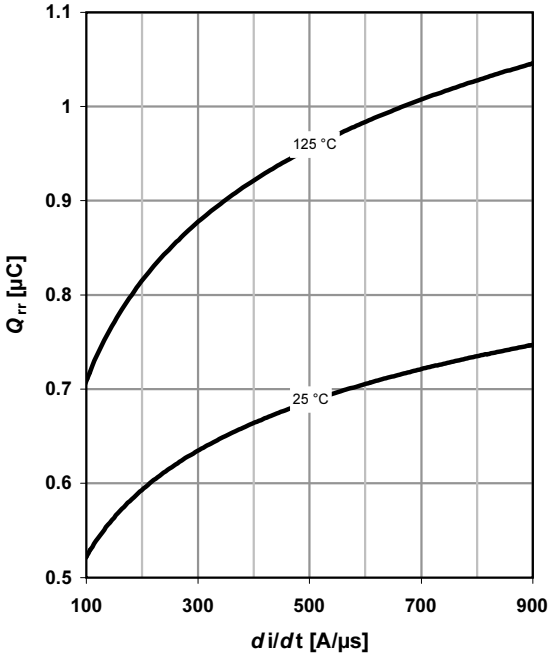
17 Typ. reverse recovery charge

$Q_{rr}=f(I_S)$; parameter: $di/dt=100$ A/µs

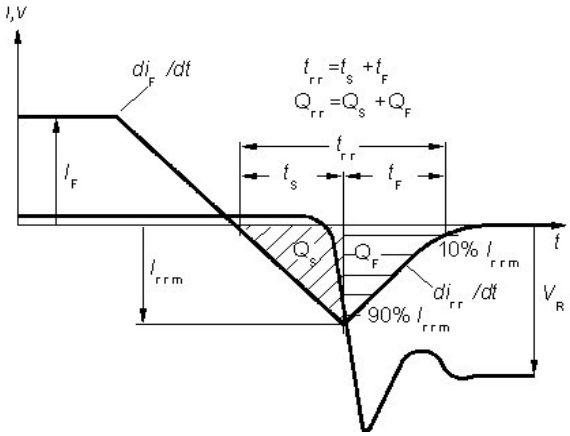


18 Typ. reverse recovery charge

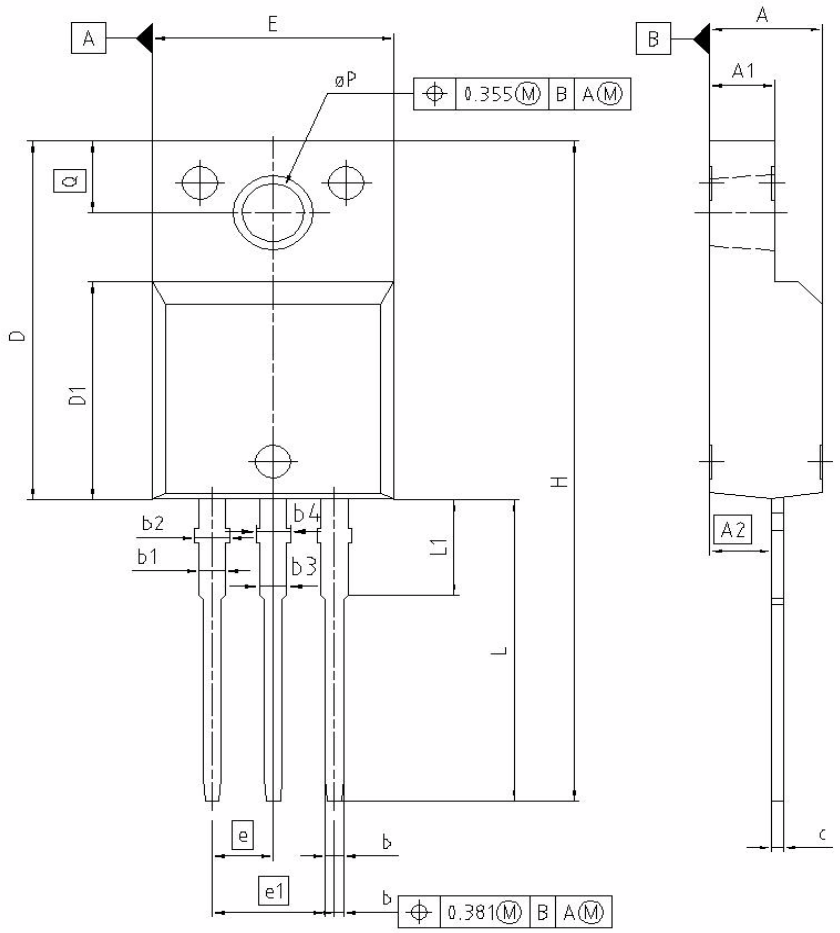
$Q_{rr}=f(di/dt)$; parameter: $I_D=6.6$ A



Definition of diode switching characteristics



PG-TO220-3-31; -3-111: Outlines/Fully isolated package (2500VAC; 1 minute)



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.55	4.85	0.179	0.191
A1	2.55	2.85	0.100	0.112
A2	2.42	2.72	0.095	0.107
b	0.65	0.85	0.026	0.033
b1	0.95	1.33	0.037	0.052
b2	0.95	1.51	0.037	0.059
b3	0.65	1.33	0.026	0.052
b4	0.65	1.51	0.026	0.059
c	0.40	0.63	0.016	0.025
D	15.85	16.15	0.624	0.636
D1	9.53	9.83	0.375	0.387
E	10.35	10.65	0.407	0.419
e	2.54		0.100	
e1	5.08		0.200	
N	3		3	
H	29.45	29.75	1.159	1.171
L	13.45	13.75	0.530	0.541
L1	3.15	3.45	0.124	0.136
øP	2.95	3.20	0.116	0.126
Q	3.15	3.50	0.124	0.138

REFERENCE	../..
SCALE	0 2.5 0 2.5 5mm
EUROPEAN PROJECTION	
ISSUE DATE	08-01-2007
FILE	TO220_2

Dimensions in mm/ inches

Published by
Infineon Technologies AG
81726 München, Germany
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